

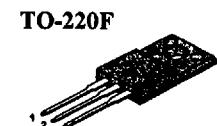
Advanced Power MOSFET

IRLSZ44A

FEATURES

- Logic Level Gate Drive
- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 10 μ A (Max.) @ $V_{DS} = 60V$
- Lower $R_{DS(ON)}$: 0.02 Ω (Typ.)

$BV_{DSS} = 60 V$
 $R_{DS(on)} = 0.025 \Omega$
 $I_D = 30 A$



1.Gate 2. Drain 3. Source

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V_{DSS}	Drain-to-Source Voltage	60	V
I_D	Continuous Drain Current ($T_c=25^\circ C$)	30	A
	Continuous Drain Current ($T_c=100^\circ C$)	21	
I_{DM}	Drain Current-Pulsed	120	A
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy	771	mJ
I_{AR}	Avalanche Current	30	A
E_{AR}	Repetitive Avalanche Energy	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt	5.5	V/ns
P_D	Total Power Dissipation ($T_c=25^\circ C$)	45	W
	Linear Derating Factor	0.3	W/ $^\circ C$
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 to +175	$^\circ C$
T_L	Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5-seconds	300	

Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
R_{aC}	Junction-to-Case	—	3.33	$^\circ C/W$
R_{sJA}	Junction-to-Ambient	—	62.5	



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Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
BV_{DSS}	Drain-Source Breakdown Voltage	60	—	—	V	$V_{\text{GS}}=0\text{V}, I_D=250\text{ }\mu\text{A}$
$\Delta \text{BV}/\Delta T_J$	Breakdown Voltage Temp. Coeff.	—	0.056	—	$\text{V}/^\circ\text{C}$	$I_D=250\text{ }\mu\text{A}$ See Fig 7
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.0	—	2.0	V	$V_{\text{DS}}=5\text{V}, I_D=250\text{ }\mu\text{A}$
I_{GSS}	Gate-Source Leakage, Forward	—	—	100	nA	$V_{\text{GS}}=20\text{V}$
	Gate-Source Leakage, Reverse	—	—	-100		$V_{\text{GS}}=-20\text{V}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	10	μA	$V_{\text{DS}}=60\text{V}$
		—	—	100		$V_{\text{DS}}=48\text{V}, T_C=150^\circ\text{C}$
$R_{\text{DS(on)}}$	Static Drain-Source On-State Resistance	—	—	0.025	Ω	$V_{\text{GS}}=5\text{V}, I_D=15\text{A}$ ④
g_{fs}	Forward Transconductance	—	33	—	S	$V_{\text{DS}}=30\text{V}, I_D=15\text{A}$ ④
C_{iss}	Input Capacitance	—	1530	1990	pF	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1\text{MHz}$ See Fig 5
C_{oss}	Output Capacitance	—	555	640		
C_{rss}	Reverse Transfer Capacitance	—	225	260		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	14	40	ns	$V_{\text{DD}}=30\text{V}, I_D=50\text{A},$ $R_G=4.6\Omega$ See Fig 13 ④ ⑤
t_r	Rise Time	—	24	60		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	43	95		
t_f	Fall Time	—	37	85		
Q_g	Total Gate Charge	—	42	55	nC	$V_{\text{DS}}=48\text{V}, V_{\text{GS}}=5\text{V},$ $I_D=50\text{A}$ See Fig 6 & Fig 12 ④ ⑤
Q_{gs}	Gate-Source Charge	—	12	—		
Q_{gd}	Gate-Drain("Miller") Charge	—	20	—		

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
I_s	Continuous Source Current	—	—	30	A	Integral reverse pn-diode in the MOSFET
I_{SM}	Pulsed-Source Current ①	—	—	120		
V_{SD}	Diode Forward Voltage ④	—	—	1.8	V	$T_J=25^\circ\text{C}, I_s=30\text{A}, V_{\text{GS}}=0\text{V}$
t_{rr}	Reverse Recovery Time	—	72	—	ns	$T_J=25^\circ\text{C}, I_F=50\text{A}$ $dI/dt=100\text{A}/\mu\text{s}$ ④
Q_{rr}	Reverse Recovery Charge	—	0.133	—		

Notes :

① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature

② $L=1\text{mH}, I_{AS}=30\text{A}, V_{DD}=25\text{V}, R_o=27\Omega$, Starting $T_J=25^\circ\text{C}$

③ $I_{SD} \leq 50\text{A}, di/dt \leq 350\text{A}/\mu\text{s}, V_{DD} \leq \text{BV}_{\text{DSS}}$, Starting $T_J=25^\circ\text{C}$

④ Pulse Test : Pulse Width = 250 μs , Duty Cycle $\leq 2\%$

⑤ Essentially Independent of Operating Temperature

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Fig 1. Output Characteristics

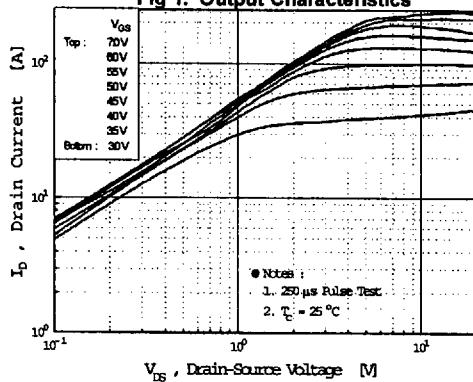


Fig 2. Transfer Characteristics

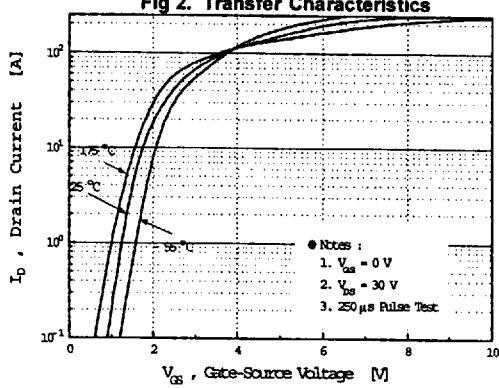


Fig 3. On-Resistance vs. Drain Current

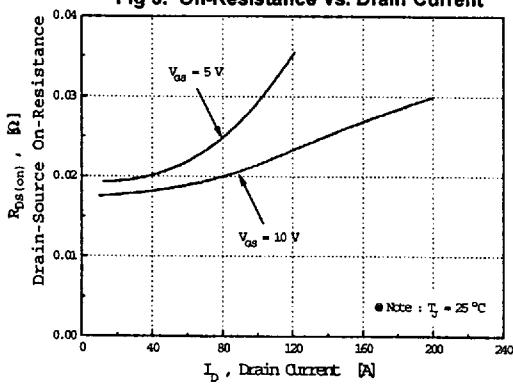


Fig 4. Source-Drain Diode Forward Voltage

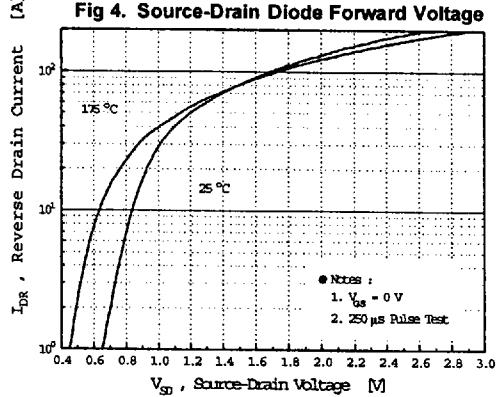


Fig 5. Capacitance vs. Drain-Source Voltage

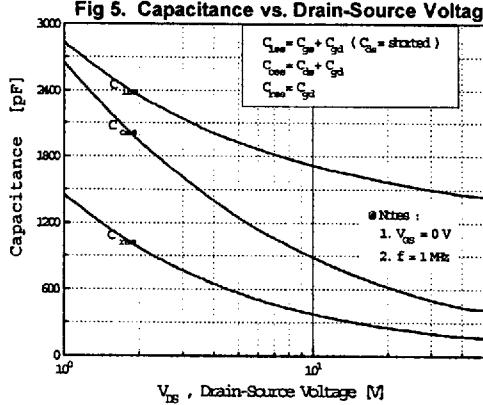
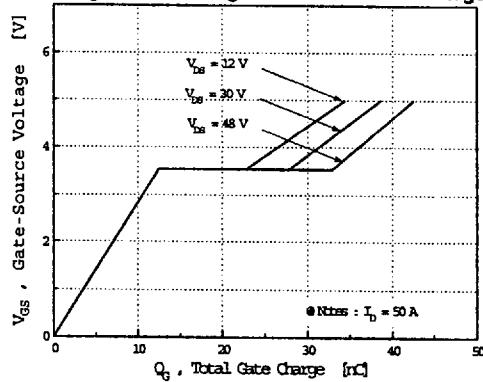


Fig 6. Gate Charge vs. Gate-Source Voltage



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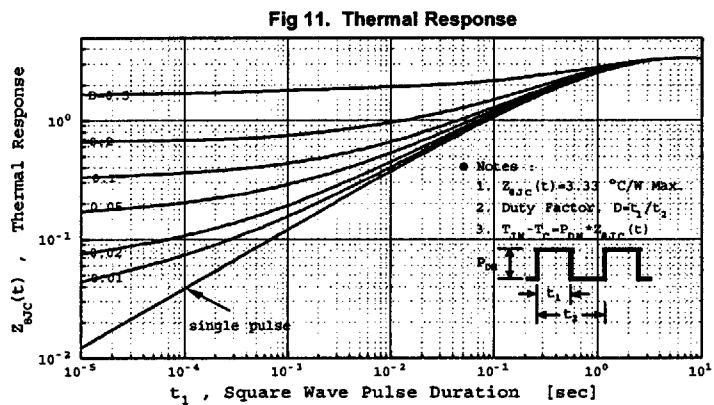
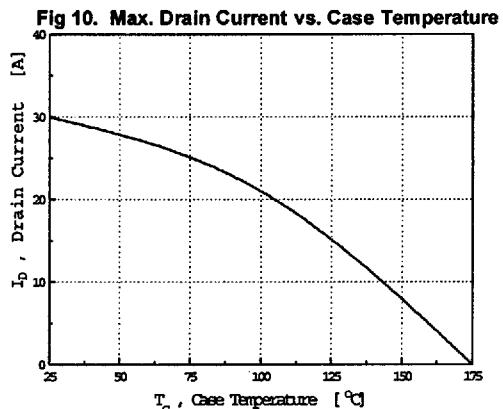
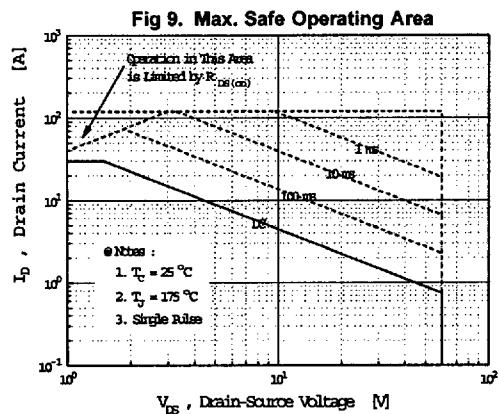
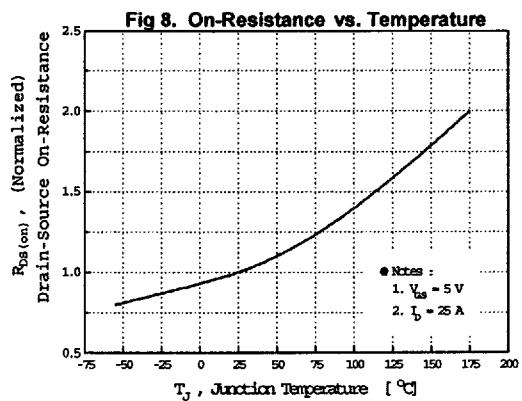
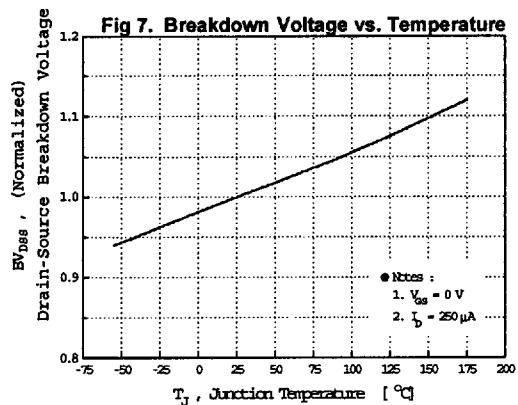


Fig 12. Gate Charge Test Circuit & Waveform

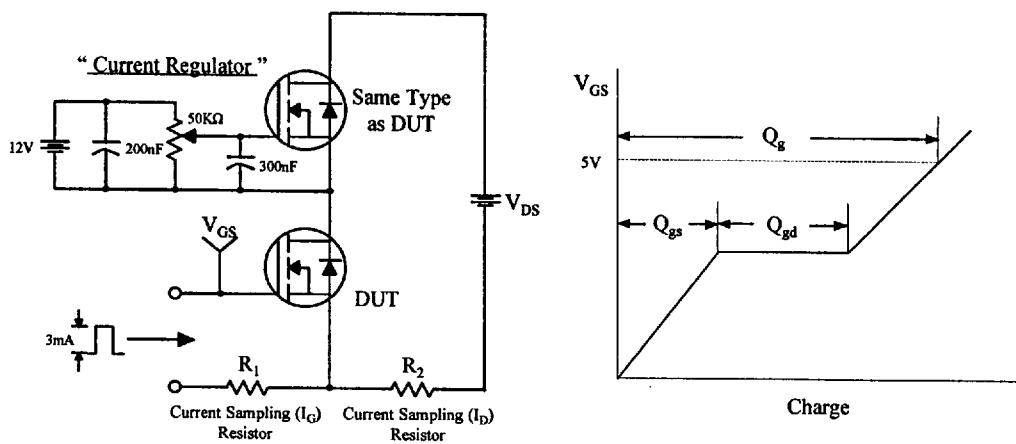


Fig 13. Resistive Switching Test Circuit & Waveforms

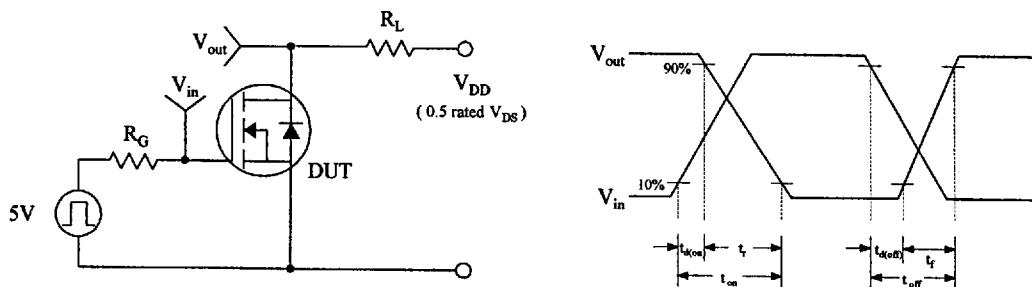
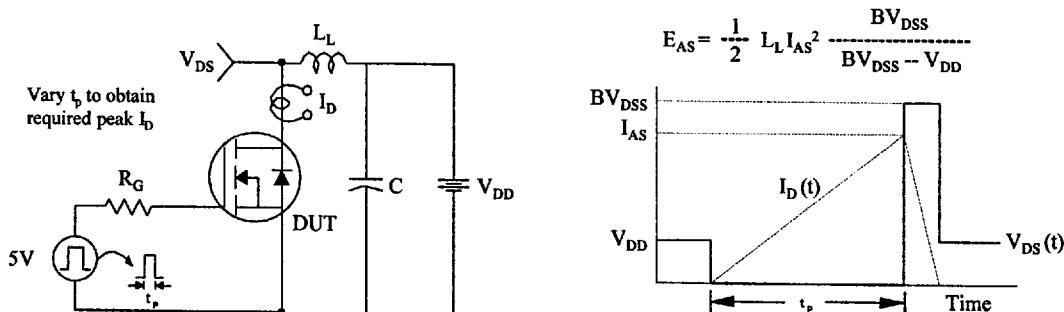


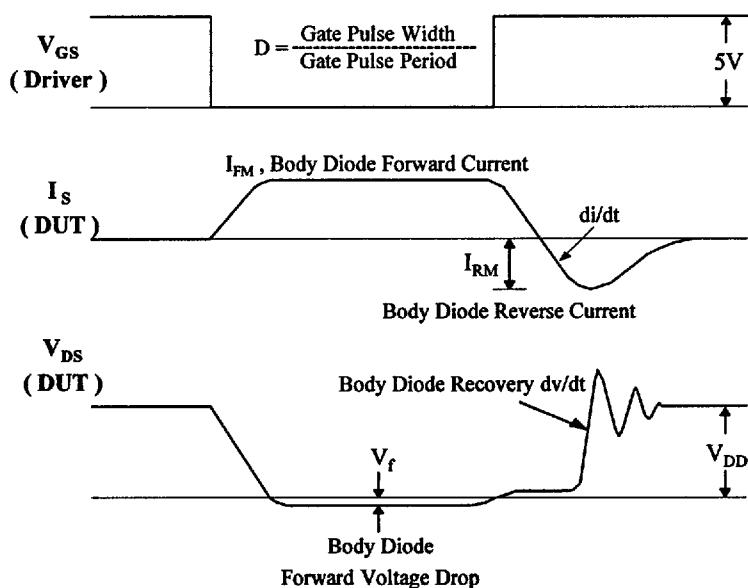
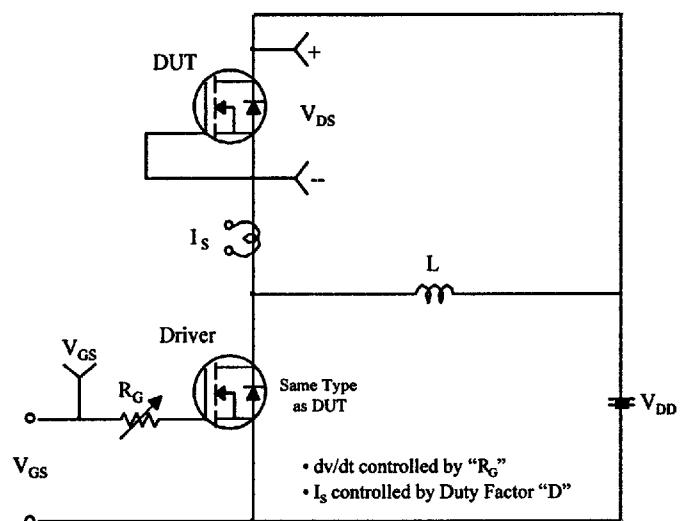
Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



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Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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